

RTHC-5030

RELIABILITY DATA

DWG. No.SC575-RTHC-30-001			
QA	R&D		
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The following data are typical values. As all units have nearly the same characteristics, the data to be considered as ability values.

1. Calculated values of MTBF

MODEL : RTHC-5030

(1) Calculating Method

Calculated based on parts stress reliability projection of MIL-HDBK-217F NOTICE2.

Individual failure rates λ_G is given to each part and MTBF is calculated by the count of each part.

$$MTBF = \frac{1}{\lambda_{equip}} = \frac{1}{\sum_{i=1}^n N_i (\lambda_G \pi_Q)_i} \times 10^6 \text{ (hours)}$$

- λ_{equip} : Total equipment failure rate (Failure / 10^6 Hours)
 λ_G : Generic failure rate for the i th generic part (Failure/ 10^6 Hours)
 N_i : Quantity of i th generic part
 N : Number of different generic part categories
 π_Q : Generic quality factor for the i th generic part ($\pi_Q = 1$)

(2) MTBF Values

G_F : Ground, Fixed

$$\underline{MTBF = 1,998,242 \text{ (Hours)}}$$

2. Vibration Test

MODEL : RTHC-5030 (Representation Product : RTHN-5150)

(1) Vibration Test Class

Frequency Variable Endurance Test

(2) Equipment Used

Controller VS-1000-6, Vibrator 905-FN (IMV CORP.)

(3) The Number of D.U.T. (Device Under Test)

2 units

(4) Test Condition

- Frequency : 10~55Hz
- Amplitude : 0.7mm, Sweep for 1 min.
- Dimension and times : X, Y and Z directions for 0.5 hours each.

(5) Test Method

Fix the D.U.T. on the fitting-stage

(6) Test Results

PASS

Typical Sample Data

Check item	Spec.		Before Test	After Test
Attenuation (dB)	Differential Mode : 25dBmin.	0.2 MHz	75.15	75.10
		30 MHz	56.05	56.05
	Common Mode : 25dBmin.	0.1 MHz	32.80	32.80
		10 MHz	38.70	38.20
Leakage Current (mA)	5mA max.(500V, 60Hz)	Line1	2.68	2.67
		Line2	2.68	2.67
		Line3	2.69	2.68
DC Resistance (mΩ)	6m Ω max.		2.54	2.54
Test Voltage	L-L : 2192Vdc 60s. L-E : 2500Vac 60s.		OK	OK
Isolation Resistance (MΩ)	100M Ω min. (500Vdc 60s)		1.0 x 10 ⁷	1.0 x 10 ⁷

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3. Heat Cycle Test

MODEL : RTHC-5030 (Representation Product : RTHN-5150)

(1) Equipment Used

TEMPERATURE CHAMBER TSA-71H-W (ESPEC CORP.)

(2) The Number of D.U.T. (Device Under Test)

2 units

(3) Test Conditions

- Ambient Temperature : -25~+85°C
- Test Cycles : 100cycles



(4) Test Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above cycles, After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

(5) Test Results

PASS

Typical Sample Data

Check item	Spec.		Before Test	After Test
Attenuation (dB)	Differential Mode : 25dBmin.	0.2 MHz	68.95	73.65
		30 MHz	57.70	54.75
	Common Mode : 25dBmin.	0.1 MHz	33.50	31.50
		10 MHz	40.25	40.40
Leakage Current (mA)	5mA max.(500V, 60Hz)	Line1	2.69	2.63
		Line2	2.67	2.65
		Line3	2.67	2.65
DC Resistance (mΩ)	6m Ω max.		2.47	2.44
Test Voltage	L-L : 2192Vdc 60s. L-E : 2500Vac 60s.		OK	OK
Isolation Resistance (MΩ)	100M Ω min. (500Vdc 60s)		1.0 x 10 ⁷	1.0 x 10 ⁷

4. Humidity Test

MODEL : RTHC-5030 (Representation Product : RTHN-5150)

(1) Equipment Used

TEMP. & HUMID. CHAMBER PR-4KT (ESPEC CORP.)

(2) The Number of D.U.T. (Device Under Test)

2 units

(3) Test Conditions

- Ambient Temperature : +40°C
- Test Time : 500 hours
- Ambient Humidity : 90~95% RH No Dewdrop

(4) Test Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions. After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

(5) Test Results

PASS

Typical Sample Data

Check item	Spec.		Before Test	After Test
Attenuation (dB)	Differential Mode : 25dBmin.	0.2 MHz	71.45	74.75
		30 MHz	54.85	49.00
	Common Mode : 25dBmin.	0.1 MHz	33.40	33.50
		10 MHz	39.15	39.90
Leakage Current (mA)	5mA max.(500V, 60Hz)	Line1	2.71	2.66
		Line2	2.70	2.66
		Line3	2.69	2.66
DC Resistance (mΩ)	6m Ω max.		2.51	2.44
Test Voltage	L-L : 2192Vdc 60s. L-E : 2500Vac 60s.		OK	OK
Isolation Resistance (MΩ)	100M Ω min. (500Vdc 60s)		1.0 x 10 ⁷	1.0 x 10 ⁷

5. High Temperature Resistance Test

MODEL : RTHC-5030 (Representation Product : RTHN-5300)

(1) Equipment Used

TEMPERATURE CHAMBER PHH-300 (ESPEC CORP.)

(2) The Number of D.U.T. (Device Under Test)

2 units

(3) Test Conditions

- Ambient Temperature : +50°C
- Test Time : 500 hours
- Operating : DC 300A

(4) Test Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions. After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

(5) Test Results

PASS

Typical Sample Data

Check item	Spec.		Before Test	After Test
Attenuation (dB)	Differential Mode : 25dBmin.	0.2 MHz	75.80	78.15
		30 MHz	34.25	38.60
	Common Mode : 25dBmin.	0.5 MHz	34.15	34.40
		6 MHz	38.60	29.55
Leakage Current (mA)	5mA max.(500V, 60Hz)	Line1	2.72	2.65
		Line2	2.72	2.66
		Line3	2.72	2.66
DC Resistance (mΩ)	2m Ω max.		1.02	0.99
Test Voltage	L-L : 2192Vdc 60s. L-E : 2500Vac 60s.		OK	OK
Isolation Resistance (MΩ)	100M Ω min. (500Vdc 60s)		1.0 x 10 ⁷	1.0 x 10 ⁷

6. Low Temperature Storage Test

MODEL : RTHC-5030 (Representation Product : RTHN-5150)

(1) Equipment Used

TEMPERATURE CHAMBER PG-2FT (ESPEC CORP.)

(2) The Number of D.U.T. (Device Under Test)

2 units

(3) Test Conditions

- Ambient Temperature : -25°C
- Test Time : 500 hours

(4) Test Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions. After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

(5) Test Results

PASS

Typical Sample Data

Check item	Spec.		Before Test	After Test
Attenuation (dB)	Differential Mode : 25dBmin.	0.2 MHz	69.10	71.70
		30 MHz	54.25	63.80
	Common Mode : 25dBmin.	0.1 MHz	32.85	32.90
		10 MHz	40.20	40.40
Leakage Current (mA)	5mA max.(500V, 60Hz)	Line1	2.73	2.65
		Line2	2.69	2.65
		Line3	2.69	2.65
DC Resistance (mΩ)	6m Ω max.		2.48	2.45
Test Voltage	L-L : 2192Vdc 60s. L-E : 2500Vac 60s.		OK	OK
Isolation Resistance (MΩ)	100M Ω min. (500Vdc 60s)		1.0 x 10 ⁷	1.0 x 10 ⁷